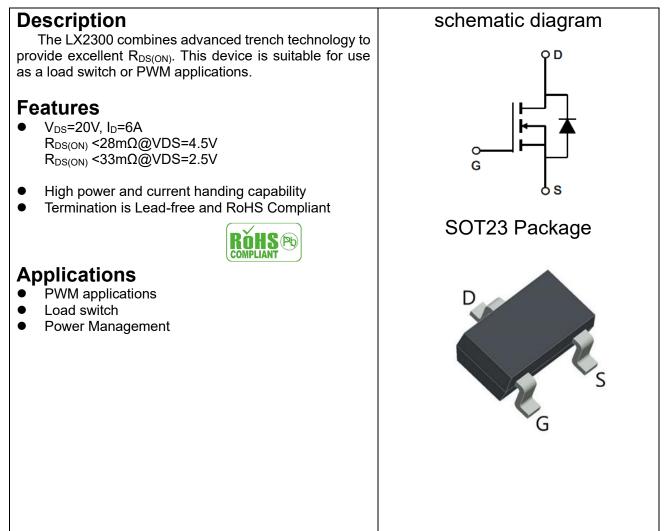


CHIPLINK N-Channel Enhancement Mode Power MOSFET



Maximum Ratings(T_A=25°C unless otherwise noted)

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	V _{DS}	20	V
Gate-Source Voltage	V _{GS}	±10	V
Continuous Drain Current	I _D	6	A
Pulsed Drain Current ^B	I _{DM}	20	A
Maximum Power Dissipation ^A	PD	1.25	W
Junction and Storage Temperature Range	TJ, T _{STG}	-55 To 150	°C

Thermal Characteristic

Thermal Resistance, Junction to Ambient	R _{QJA}	100	°C/W	
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Electrical Characteristics (T_A=25°C unless otherwise specified)

Parameter	Symbol	Test conditions	MIN	TYP	MAX	UNIT
Drain-Source Breakdown Voltage	BV _{DSS}	$V_{GS}=0V$, $I_D=250uA$	20			V
Gate-Threshold Voltage	V _{th(GS)}	V_{DS} = V_{GS} , I_D =250 uA	0.4	0.65	1.1	V
Gate-body Leakage	IGSS	$V_{DS}=0V, V_{GS}=\pm 10V$			±100	nA
Zero Gate Voltage Drain Current	IDSS	$V_{DS}=20V, V_{GS}=0V$			1	uA
Drain Source On Resistance	D	V _{GS} =4.5V, I _D =2.5A		19	28	mΩ
Drain-Source On-Resistance	R _{DS(ON)}	V _{GS} =2.5V, I _D =2.0A		22	33	mΩ
Forward Transconductance	g fs	$V_{DS}=5V, I_{D}=1.0A$	2			S
Dynamic Characteristics						
Input Capacitance	Ciss			457		
Output Capacitance	Coss	$V_{DS} = 10V, V_{GS} = 0V,$ F=1MHz		71		pF
Reverse Transfer Capacitance	C _{rss}			60		
Switching Capacitance						
Turn-on Delay Time	t _{d(on)}			4.1		nS
Turn-on Rise Time	tr	V _{DD} = 10V, R _L =2.9Ω		11.6		nS
Turn-off Delay Time	t _{d(off)}	$V_{GS} = 4.5V, R_{GEN} = 3\Omega$		25		nS
Turn-off Fall Time	t _f			7.6		nS
Total Gate Charge	Qg	$V_{DS} = 10V, I_{D} = 2A,$		6.6		nC
Gate-Source Charge	Q _{gs}	V _{GS} =4.5V		0.4		nC
Gate-Drain Charge	Q _{gd}			2		nC
Drain-Source Diode Characteristics						
Diode Forward Voltage	V _{SD}	V _{GS} =0V, I _D =5A			1.2	V
Diode Forward Current	ls				2.0	Α

Notes:

- A. The Power dissipation P_D is based on $T_{J(MAX)}=150$ °C, using ≤10s junction-to ambient thermal resistance.
- B. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150 °C.Ratings are based on low frequency and duty cycles to keep initial T_J=25 °C.
- C. The Static characteristics in Figures are obtained using \langle 300 μ s pulses, duty cycle 2% max.



Typical Electrical and Thermal Characteristics

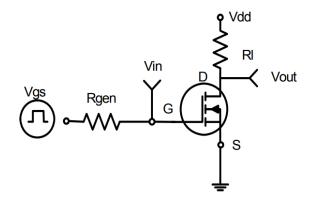


Figure 1:Switching Test Circuit

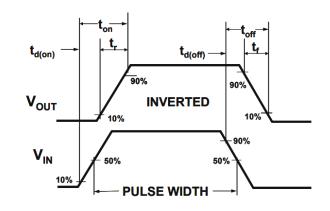


Figure 2:Switching Waveforms

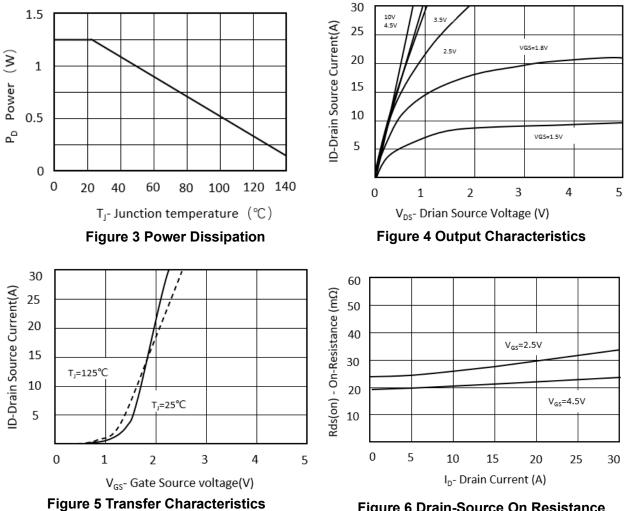


Figure 6 Drain-Source On Resistance



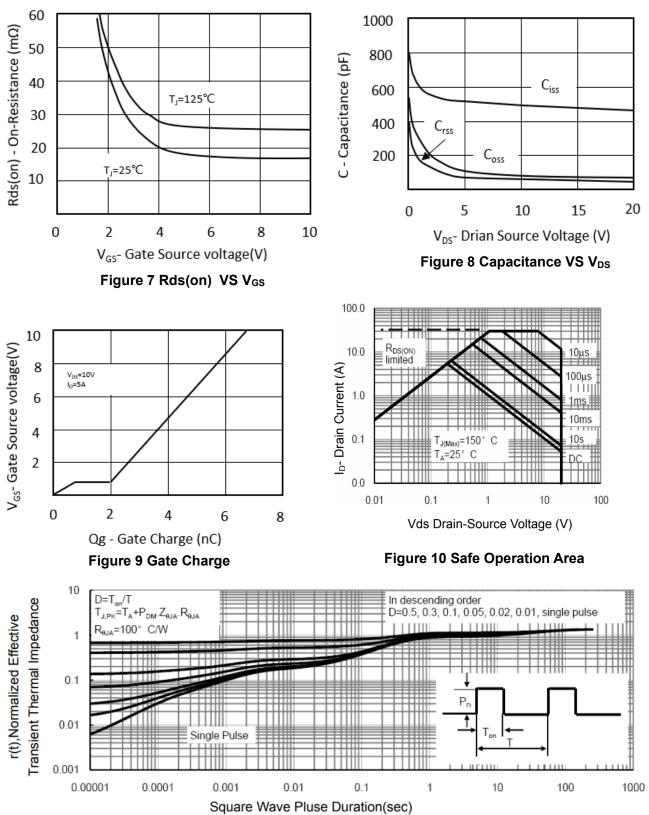
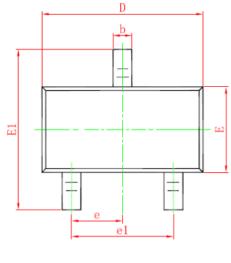
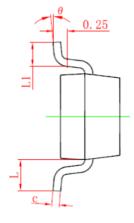


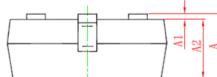
Figure 11 Normalized Maximum Transient Thermal Impedance



SOT-23 Package Information







Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min.	Max.	Min.	Max.	
A	0.900	1.150	0.035	0.045	
A1	0.000	0.100	0.000	0.004	
A2	0.900	1.050	0.035	0.041	
b	0.300	0.500	0.012	0.020	
С	0.080	0.150	0.003	0.006	
D	2.800	3.000	0.110	0.118	
E	1.200	1.400	0.047	0.055	
E1	2.250	2.550	0.089	0.100	
е	0.950 TYP.		0.037 TYP.		
e1	1.800	2.000	0.071	0.079	
L	0.550 REF.		0.022 REF.		
L1	0.300	0.500	0.012	0.020	
θ	0°	8°	0°	8°	

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